Search Notes



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FUNAHASHI, MASAKAZU

Examiner

Dawn Garrett

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SEARCH NOTES			
Search Notes	Date	Examiner	
EIC 1700 STIC structure search - see printout	7-22-08	DG	
Inventor Name Search	7-27-08	DG	
EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	7-27-08	DG	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
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